

# High elasticity of CsPbBr<sub>3</sub> perovskite nanowires for flexible electronics

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## ABSTRACT

Due to the enhanced ambient structural stability and excellent optoelectronic properties, all-inorganic metal halide perovskite nanowires have become one of the most attractive candidates for flexible electronics, photovoltaics and optoelectronics. Their elastic property and mechanical robustness become the key factors for device applications under realistic service conditions with various mechanical loadings. Here, we demonstrate that high tensile elastic strain (~ 4% to ~ 5.1%) can be achieved in vapor-liquid-solid-grown single-crystalline CsPbBr<sub>3</sub> nanowires through *in situ* scanning electron microscope (SEM) buckling experiments. Such high flexural elasticity can be attributed to the structural defect-scarce, smooth surface, single-crystallinity and nanomechanical size effect of CsPbBr<sub>3</sub> nanowires. The mechanical reliability of CsPbBr<sub>3</sub> nanowire-based flexible photodetectors was examined by cyclic bending tests, with no noticeable performance deterioration observed after 5,000 cycles. The above results suggest great application potential for using all-inorganic perovskite nanowires in flexible electronics and energy harvesting systems.

## KEYWORDS

perovskite nanowire, CsPbBr<sub>3</sub>, nanomechanics, *in situ* testing, elasticity, flexible electronics

## 1 Introduction

In recent years, perovskite materials have shown tremendous potential in developing photovoltaic devices, light-emitting devices and displays because of their excellent light-harvesting capability, high charge carrier mobility, long carrier diffusion length, high color purity and wide color gamut [1–3], etc. Among them, all-inorganic metal halide perovskites are attracting more and more attention due to their enhanced ambient stability than hybrid perovskites and retained superior optoelectronic properties [4–6]. As a promising candidate in the field of flexible electronics (e.g. flexible solar cells, artificial skins, wearable electronic textiles) [7–9], perovskite materials are expected to function under different mechanical strain states for practical applications. Therefore, it's crucial for perovskites to achieve high mechanical elasticity. Decreasing the sample size to micro/nanoscale has been proved to be a feasible way to obtain substantial elasticity in crystalline materials that are brittle at the bulk scale [10–19]. Notably, elastic strain as high as ~ 16% has been achieved in Si nanowire through uniaxial *in situ* tensile straining in a SEM [16]. Maximum tensile strains up to ~ 9%–13% have been reported by bending diamond nanoneedles inside SEM or transmission electron microscope (TEM) [18, 19]. Besides, nanostructured semiconductors showed much better performances in developing electronics than their

bulk or thin-film counterparts for enhanced carrier mobilities [20–22]. The above researches give valuable insights for developing next-generation flexible electronics by resorting to all-inorganic perovskite nanowires.

Furthermore, as perovskites serve as the most crucial and believed to be the mechanically weakest component among flexible devices, their elastic limit determines the flexibility and reliability of devices. However, at present, the flexibility of perovskite materials was usually revealed by the bending tests of whole electronics [7, 23, 24], in which the device performance commonly degraded with increasing bending cycles and degree [7, 25, 26]. Whereas only limited attention has been paid to explore the underlying mechanisms of performance deterioration by investigating the deformation and microstructure evolution in free-standing perovskite materials [27]. Experimentally probing the intrinsic mechanical properties (particularly, the elastic limit) and structural evolution of individual perovskite nanostructures through nanomechanical approach is essential for guiding the future devices design and reliable applications.

Here, in this study, we report the high flexural elasticity of “individual” all-inorganic CsPbBr<sub>3</sub> perovskite nanowires (NWs) through the *in situ* SEM compression-induced buckling experiments, with the finite element method (FEM) simulations were complemented to quantify the local strain distributions of deformed NWs [19]. Furthermore, we demonstrate the

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excellent mechanical reliability of CsPbBr<sub>3</sub> NW-based flexible photodetectors (PDs) through cyclic bending tests. The present results evidently indicate the potential of CsPbBr<sub>3</sub> NWs for high-performance flexible electronics.

## 2 Experimental

### 2.1 Material synthesis

The materials used in this study are all-inorganic perovskite CsPbBr<sub>3</sub> nanowires prepared by direct vapor-liquid-solid synthesis method. All chemicals used in this work were purchased from Sigma-Aldrich. First of all, an aqueous suspension containing 150-nm-diameter Sn nanoparticles ( $\geq 99\%$ , Aldrich) was drop-casted onto the 50 nm thick thermally grown SiO<sub>2</sub>/Si substrates, as the growth substrate. To prepare the CsPbBr<sub>3</sub> source powder, CsBr and PbBr<sub>2</sub> powders with a molar ratio of 2:1 were mixed together and then annealed at 430 °C for 30 min. In a CVD synthesis system, the CsPbBr<sub>3</sub> source powder and growth substrates were placed at the high-temperature zone (440 °C) and low-temperature zone (310 °C), respectively. During the growth, the chamber pressure was set to 1.2 Torr, whereas the Ar gas with a flow speed of 80 sccm was used as a carrier gas. After the growth duration, CsPbBr<sub>3</sub> NWs were obtained on the growth substrates.

### 2.2 Material characterization

The TEM characterization of nanowires were obtained by using a field-emission transmission electron microscope (JEOL, JEM-2100F FE-TEM). The SEM images were obtained by using a field-emission scanning electron microscope (FEI, Quanta 450 FE-SEM). X-ray diffraction (XRD) test was conducted on a Philips powder diffractometer. Elemental mapping was performed on an energy-dispersive X-ray spectroscopy (EDS) detector attached to the FEI Quanta 450 FE-SEM.

### 2.3 *In situ* nanomechanical characterization

The protocol of *in situ* compressive mechanical test of CsPbBr<sub>3</sub> NWs was based on a quantitative nanoindenter (Hysitron PI85 PicoIndenter) in conjunction with a SEM (FEI Quanta 450 field-emission SEM). A substrate with CsPbBr<sub>3</sub> nanowires grown vertically on it has been fixed on the stage, then careful adjustment of the relative position of indenter and NW was conducted to ensure they are well-contacted. The uniaxial compressive tests can be achieved by the downwards movements of diamond indenter under displacement control mode with a constant loading velocity of 20 nm/s (when the desired loading displacement amplitude exceeded the displacement range of nanoindenter, sample stage was firstly raised upwards to achieve large relative displacement). The deformation process of NW was simultaneously recorded by SEM.

### 2.4 FEM analyses

We carried out the finite element method (FEM) simulation using the commercial ABAQUS software package (Dassault Systèmes Simulia Corp.) to quantify the strain distribution of deformed CsPbBr<sub>3</sub> NWs under buckling/bending [19]. Nonlinear elastic deformation was taken into account in this study. The Young's modulus ( $E$ ) is 20 GPa and the Poisson ratio ( $\nu$ ) is 0.3. In this simulation, the displacement and rotation at the bottom of the NW was fixed; the displacement constraint was applied to the top of the NW. For the NW in Fig. 2, according to the calculation of the length of NW before and after deformation, it can be seen that the deformation of NW is out of the observing plane. The strain state was obtained by following

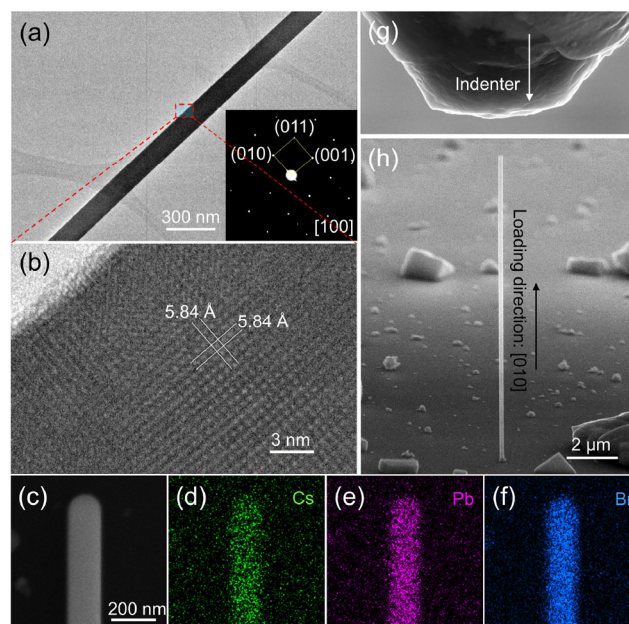
the actual rotated geometry for the NW. Since the difference between the maximum principal strain and maximum tensile strain within the NW surface is actually less than 0.5% in FEM simulations, the extracted maximum principal strain from FEM simulations for each NW is equivalent to the maximum elastic tensile strain.

### 2.5 Device fabrication and characterization

To fabricate CsPbBr<sub>3</sub> NW-based photodetectors, a contact transfer method was used to transfer the CsPbBr<sub>3</sub> NWs from the growth substrates to the polyimide (PI) substrates. After that, shadow mask was employed to define the source and drain regions (channel lengths are 10  $\mu\text{m}$ ), and then 50-nm-thick Au electrodes were deposited by thermal evaporation. Agilent 4155C semiconductor analyzer was used to examine the electrical performance of CsPbBr<sub>3</sub> NW devices in a standard probe station. For photodetector measurements, the wavelength of light source was 450 nm, and the incident light power was measured by a power meter (PM400, Thorlabs).

## 3 Results and discussion

Figure 1(a) shows the bright-field transmission electron microscope (TEM) image of a typical CsPbBr<sub>3</sub> NW with a diameter of  $\sim 130$  nm. The inset depicts the selected-area electron diffraction (SAED) pattern of the NW, which is taken along [100] zone axis, illustrating the single-crystalline cubic structure and  $\langle 100 \rangle$ -oriented growth direction of the NW. The crystal structure was also verified by the XRD (Fig. S1 in the Electronic Supplementary Material (ESM)), in which only diffraction peaks of cubic CsPbBr<sub>3</sub> were detected. The high resolution TEM (HRTEM) in Fig. 1(b) illustrates the excellent crystallinity and defect-scarce characteristic of the VLS-grown CsPbBr<sub>3</sub> NW. Figures 1(c)–1(f) are the SEM image and corresponding EDS mappings of another CsPbBr<sub>3</sub> NW, showing the uniform



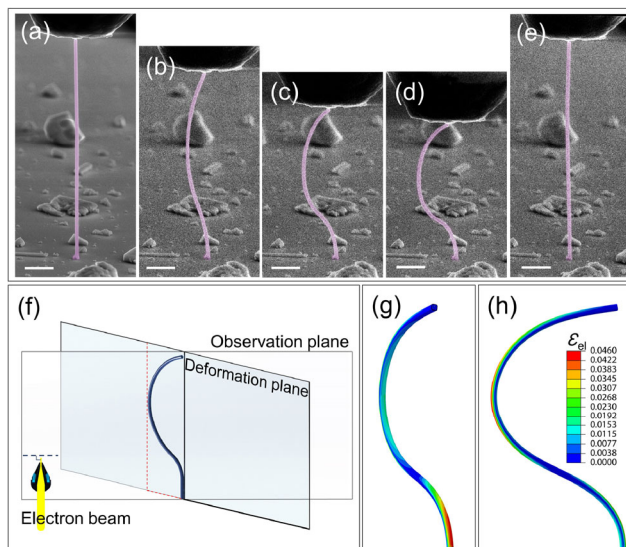
**Figure 1** Material characterization and experimental configuration. (a) Bright-field transmission electron microscope (TEM) image of a typical CsPbBr<sub>3</sub> nanowire (NW). Inset shows the corresponding selected-area electron diffraction (SAED) pattern. (b) High-resolution TEM (HRTEM) image of the region marked in (a). (c)–(f) Scanning electron microscope (SEM) image of another CsPbBr<sub>3</sub> NW and corresponding energy-dispersive X-ray spectroscopy (EDS) mappings of Cs, Pb and Br elements, respectively. (g) and (h) SEM images of the diamond indenter and a nanowire that grown vertically on the substrate, respectively.

distribution of Cs, Pb and Br elements. From above, the CsPbBr<sub>3</sub> NWs possess a quite good crystal quality with smooth surface, uniform diameter and defect-scarce single-crystallinity, these features are significant for material's mechanical properties to avoid premature failure. The configuration of *in situ* compression experiments was depicted in Figs. 1(g) and 1(h), in brief, a flat diamond indenter (Fig. 1(g)) was used to impose mechanical load on CsPbBr<sub>3</sub> NWs that grown vertically on the substrate (Fig. 1(h)) and introduce bending/buckling to the NW samples.

It is well-acknowledged that loading-unloading is the most unambiguous method for assessing the elasticity and plasticity of deformation. For elastic deformation, the deformed material could fully recover its original shape when it is unloaded; otherwise, plastic deformation occurred. Therefore, to better discern whether the deformation mode of CsPbBr<sub>3</sub> NWs is plastic or elastic, multiple loading-unloading tests were conducted. Figure 2 shows the process of *in situ* loading-unloading buckling deformation of a representative CsPbBr<sub>3</sub> NW that extracted from Movie ESM1. The NW has a diameter of ~ 215 nm and a length of ~ 14.5 μm (i.e. aspect ratio of ~ 67). Soon after loading, the NW buckled into a loop (Fig. 2(b)). Figures 2(c) and 2(d) illustrate the increasing loop curvature under the gradually increased displacement. When the NW was unloaded (Fig. 2(e)), surprisingly, it totally recovered to its original shape, which is a strong evidence for the fully reversible elastic deformability of the CsPbBr<sub>3</sub> NW.

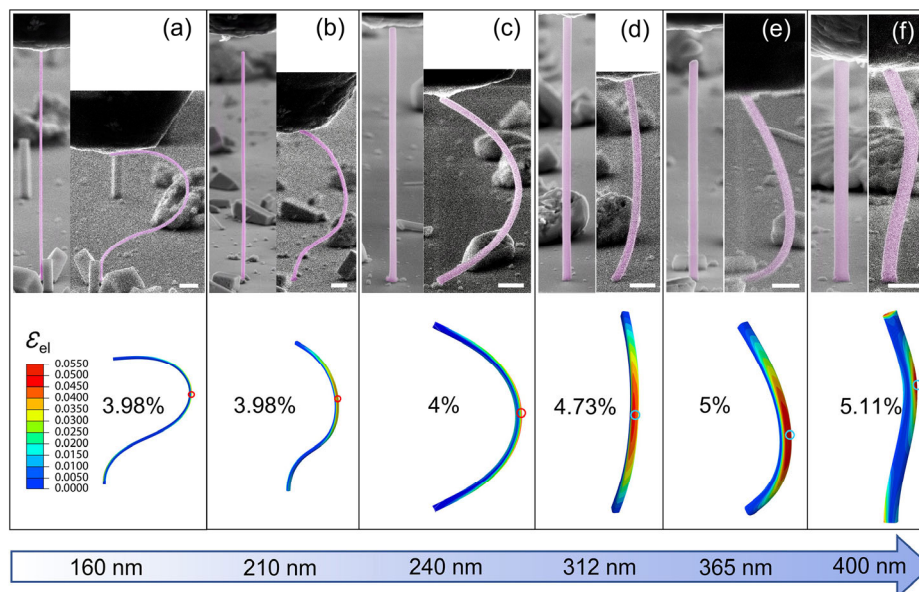
FEM simulations were complemented for the strain distribution of the deformed NW. Based on the original NW dimension and its geometry during deformation, it is found that the deformation plane of NW was not parallel with the observation plane which is perpendicular to the electron beam incident direction (Fig. 2(f)). The FEM simulations in Figs. 2(g) and 2(h) fully reproduced the NW geometry in Fig. 2(d) (on observation plane) and its' actual geometry on deformation plane, respectively. A maximum local tensile strain of ~ 4.6% was inferred. This high elasticity is especially striking for perovskite materials, which are commonly regarded as fragile. The NW also exhibited considerable plastic deformability in the following loading-unloading cycles, as illustrated in Fig. S2 in the ESM and Movie ESM2.

As the NWs prepared by VLS method are not uniform in



**Figure 2** Elastic buckling of a typical CsPbBr<sub>3</sub> NW. (a)–(e) Loading-unloading process by *in situ* nanomechanical compression. (f) Spatial relationship of the observation plane which is vertical to electron beam and the NW deformation plane. Finite element method (FEM) simulations showing the elastic tensile strain distribution of the NW geometry prior to unloading in (d) on: (g) observation plane, (h) deformation plane, respectively. Scale bar in all the figures: 2 μm.

size, to check the potential size effect on mechanical property and reproducibility of high elasticity in CsPbBr<sub>3</sub> NWs, a series of *in situ* compressions of nanowires with diameter ranging from 160 to 400 nm were conducted. Figure 3 shows the original geometry and the maximum elastic deformation of each NW. The FEM strain distribution on NWs at the largest elastic deformation were accompanied below each NW. All the NWs exhibited remarkable elastic deformability. For the NWs with diameter of 160, 210, and 240 nm, a maximum flexural elastic strain of ~ 4% can be obtained. While for the NWs with larger diameter, the maximum flexural elastic strain increased with diameter. Through Figs. 3(d)–3(f), the maximum strains were ~ 4.73%, ~ 5%, ~ 5.11% for NWs with diameter of 312, 365, and 400 nm, respectively. This size-related elasticity can be qualitatively deduced from the equation of bending



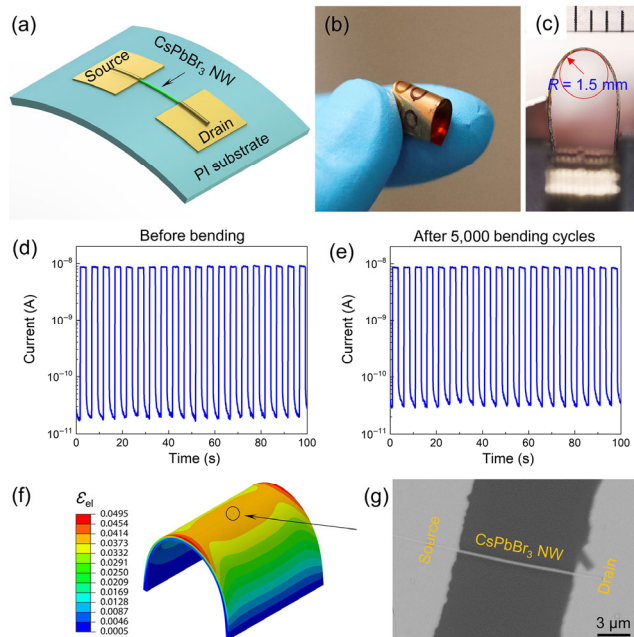
**Figure 3** Size-effect on the elasticity of CsPbBr<sub>3</sub> NWs. (a)–(f) SEM images of the original geometry and the maximum elastic deformation of each NW, the FEM strain distribution of NWs at the maximum elastic deformation were accompanied below. Scale bar in all the figures: 1 μm.

strain:  $\varepsilon = r/(r+R)\%$ , where  $r$  and  $R$  are the radius of NW and the radius of flexural curvature of deformed NW [14]. The maximum local strain of a specific NW is obtained at where has the minimum radius of curvature. As the NW diameter increases, the NW diameter grows faster than the flexural curvature, thus leading to a higher strain.

The excellent elasticity of CsPbBr<sub>3</sub> NWs mainly comes from two aspects: Firstly, the elasticity of crystalline nanomaterials is generally superior to their bulk counterparts. As the materials' characteristic dimensions are reduced to the nanoscale, the internal defects are extremely eliminated. Thus, the probability for starting a surface Griffith crack or inner grain nanocrack is linearly reduced. Secondly, the catalytic VLS growth method used in this study enables the NWs to achieve pristine single crystallinity, defect-scarce interior structure, smooth surface and uniform diameter, which are essential for NWs to avoid the stress localization, to withstand a larger range of deformation without premature fracture. It's worth mentioning that, although catalytic VLS growth method is well-known for ease of harvesting high-quality nanostructures [28, 29], non-catalytic vapor-solid (VS) growth method was more prevalence for lead halide perovskites due to the difficulty to handle ternary material systems through VLS synthesis method. The success in applying VLS method to fabricate high-quality CsPbBr<sub>3</sub> NWs [30] will give inspirations to the synthesis of other perovskite nanostructures.

Lastly, the CsPbBr<sub>3</sub> NWs were packaged into flexible photodetectors (PDs) to verify the cyclic mechanical performance for flexible device applications. Figure 4(a) gives an architecture of flexible PD, in which the Au source and drain electrodes were connected by a CsPbBr<sub>3</sub> NW channel. Flexible polyimide (PI) substrate was employed such that PD could achieve large bending deformation, as illustrated by Fig. 4(b). The performance of the as-fabricated PD was characterized in Fig. S3 in the ESM. A total of 5,000 bending cycles were performed on a PD at a fixed bending radius of 1.5 mm at ambient environment, as shown in Fig. 4(c), in which a real ruler was placed on the top as a scale bar. The device photocurrent under on/off switching light illumination (0.2 Hz) was evaluated before and after 5000 bending cycles, as depicted in Figs. 4(d) and 4(e), respectively (photocurrent after 1,000, 2,000 and 3,000 bending cycles were shown in Fig. S4 in the ESM). These photocurrent measurements suggest there is no noticeable photocurrent deterioration after bending tests.

Such robust device performance in bending tests can be attributed to the superior flexural elasticity of CsPbBr<sub>3</sub> NWs. As shown in the FEM simulation of PD device when it was bent at a radius of 1.5 mm (Fig. 4(f)), the strain on the middle of the substrate where the NW was located is around ~ 3.9%. Supposing the NW was perfectly bonded on the substrate by the Au electrodes, the maximum tensile strain on it will be same with the substrate where it was bonded. The SEM image of PD in Fig. 4(g) suggests a satisfactory bonding condition of the NW. Thus, the strain on it is  $\leq 3.9\%$ . Since the value is below the elastic limits that achieved in free-standing NWs (~ 4% to ~ 5.11%, as demonstrated in Figs. 2 and 3), the NW-based PD is totally "safe" under present bending deformation; the structural damage, e.g. plastic deformation, crack initiation, and concurrent deterioration of photoelectric performance can be avoided. As the strain on substrate surface can be lowered by decreasing the substrate thickness [31], one can expect to apply CsPbBr<sub>3</sub> NWs on ultra-thin flexible substrates to serve at more severe deformation conditions. Besides, the PD reliability also benefited from the good structural stability (i.e. resistance to humidity and oxygen) of the all-inorganic NWs at ambient



**Figure 4** Mechanical reliability of CsPbBr<sub>3</sub> NW-based photodetectors (PDs) through bending tests. (a) Architecture of a flexible PD device. (b) Optical image of a PD device showing excellent flexibility. (c) Side view of the PD device under bending status. The bending radius is 1.5 mm with a real ruler illustrated on the top as scale bar. (d) and (e) The device photocurrent under on/off switching light illumination (0.2 Hz) as a function of time that measured before bending tests and after 5,000 bending cycles, respectively. (f) FEM simulation of the PD device at a bending radius of 1.5 mm, reproducing the shape in (c), the location of Au electrodes and NW was indicated by the circle. (g) SEM image of the PD, showing the NW was well-bonded on substrate by Au electrodes

environment. The environmental stability of PD was checked, with 90% of initial photocurrent can be retained after 12 hours exposure at ambient conditions, as shown in Fig. S5 in the ESM. The long-term stability of CsPbBr<sub>3</sub> NW device can be further enhanced through surface passivation with MoO<sub>3</sub> shells, as reported in our recent work [5]. The present work has profound significance for their practical applications.

## 4 Conclusion

In summary, we uncovered the excellent flexural elasticity of VLS-grown CsPbBr<sub>3</sub> NWs through *in situ* nanomechanical measurements, where the maximum local tensile elasticity as high as ~ 4% to ~ 5.11% can be achieved. The application of CsPbBr<sub>3</sub> NWs in developing flexible devices was then revealed by cyclic bending tests of the NW photodetectors, of which the performance was almost unchanged after 5,000 bending cycles. With the merits shown above, the VLS-grown CsPbBr<sub>3</sub> NWs were proven to be one of the most promising candidates for flexible optoelectronic devices that are even capable to function under extreme deformation conditions. Experimentally achieving such high elasticity in CsPbBr<sub>3</sub> NWs is also significant for their potential applications in "elastic strain engineering (ESE)", which could potentially change their physical and chemical properties through mechanical straining alone [32, 33].

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